

Supporting Information for

Unraveling interlayer coupling effect on layer-dependent electronic and optoelectronic properties in two-dimensional semiconductors

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S1. Vacuum-layer-dependent absorption spectra and absorptivity

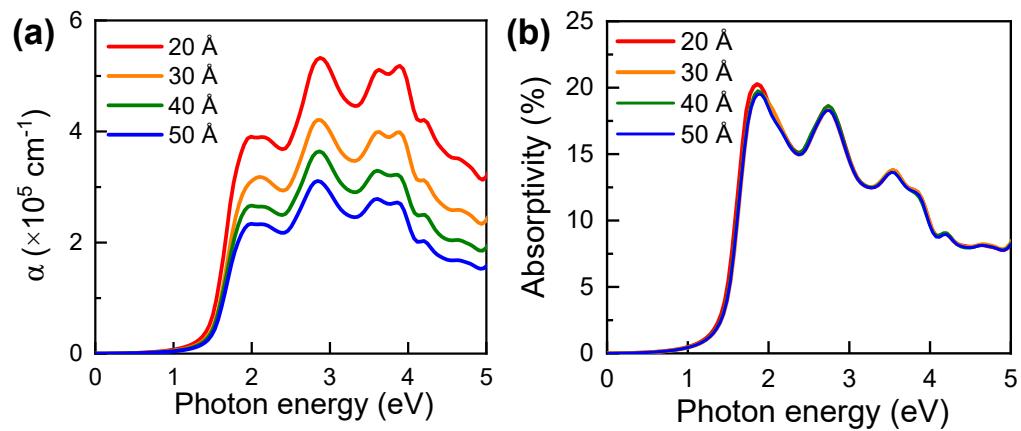


Fig. S1 (a) Absorption spectra and (b) absorptivity of monolayer PtSe₂ with different thicknesses (20~50 Å) of vacuum layer in the calculated models.

S2. Lattice and energetic parameters of 2D semiconductors

Table S1. In-plane lattice parameters (a and b), interlayer distance (d_{int}), and interlayer binding energy (E_b) of eighteen 2D semiconductors.

Materials	a (Å)	b (Å)	d_{int} (Å)	E_b (meV/Å 2)
PtS ₂	3.56	3.56	2.32	31.7
PtSe ₂	3.75	3.75	2.27	35.7
HfS ₂	3.64	3.64	3.01	21.9
HfSe ₂	3.76	3.76	3.13	22.3
TiS ₂	3.40	3.40	2.87	24.8
TiSe ₂	3.52	3.52	3.00	26.8
WS ₂	3.18	3.18	3.10	26.1
WSe ₂	3.31	3.31	3.18	25.6
MoS ₂	3.18	3.18	3.04	25.2
MoSe ₂	3.32	3.32	3.18	27.1
MoTe ₂	3.55	3.55	3.33	26.1
ReS ₂	6.41	6.51	3.63	21.1
ReSe ₂	6.65	6.78	3.41	23.1
SnS	4.07	4.31	3.63	29.3
SnSe	4.29	4.41	2.74	30.1
GeS	3.62	4.57	2.65	29.7
GeSe	3.98	4.26	2.94	29.2
BP	4.63	3.30	3.11	33.4

S3. Comparison of interlayer binding energy of 2D semiconductors between this work and previous studies

Table S2 Comparison of interlayer binding energy (E_b) of 2D semiconductors between this work and previous reports.

Materials	Methods	E_b (meV/Å ²)	References
BP	DFT-D3	33.4	This work
	optB88-vdW	29.9	1
	PBE	38.2	2
MoS ₂	DFT-D3	25.2	This work
	optB88-vdW	24.2	1
	DFT-D3	27.1	3
MoSe ₂	DFT-D3	27.1	This work
	Experiment	22.2	4
MoTe ₂	DFT-D3	26.1	This work
	PBE	23.1	2
WS ₂	DFT-D3	26.1	This work
	DFT-D3	27.9	3
GeS	DFT-D3	29.7	This work
	vdW-DF2	28.4	5
	DFT-D2	32.5	6
GeSe	DFT-D3	29.2	This work
	PBE	31.9	2
	DFT-D2	28.1	6
	vdW-DF2	30.8	5
SnSe	DFT-D3	30.1	This work
	optB88-vdW	32.1	1

S4. Comparison of interlayer binding energy and interlayer distance between the bilayer and bulk van der Waals crystals

Table S3 Comparison of interlayer binding energy (E_b) and interlayer distance (d_{int}) in twelve van der Waals crystals with bilayer and bulk structures.

Materials	Bilayer		Bulk	
	E_b (meV/Å ²)	d_{int} (Å)	E_b (meV/Å ²)	d_{int} (Å)
PtSe ₂	35.7	2.27	37.6	2.19
HfSe ₂	22.3	3.13	23.3	3.04
WS ₂	26.1	3.18	28.8	3.07
MoS ₂	25.2	3.18	27.2	3.09
ReS ₂	21.1	3.63	25.2	3.42
ReSe ₂	23.1	3.41	26.5	3.32
SnS	29.3	2.63	30.2	2.61
SnSe	30.1	2.74	30.8	2.67
GeS	29.7	2.65	30.3	2.61
GeSe	29.2	2.94	30.0	2.66
BP	33.4	3.11	37.4	3.08
Graphene	16.6	3.54	17.9	3.47

S5. Projected band structures of trilayer PtSe₂ and HfSe₂

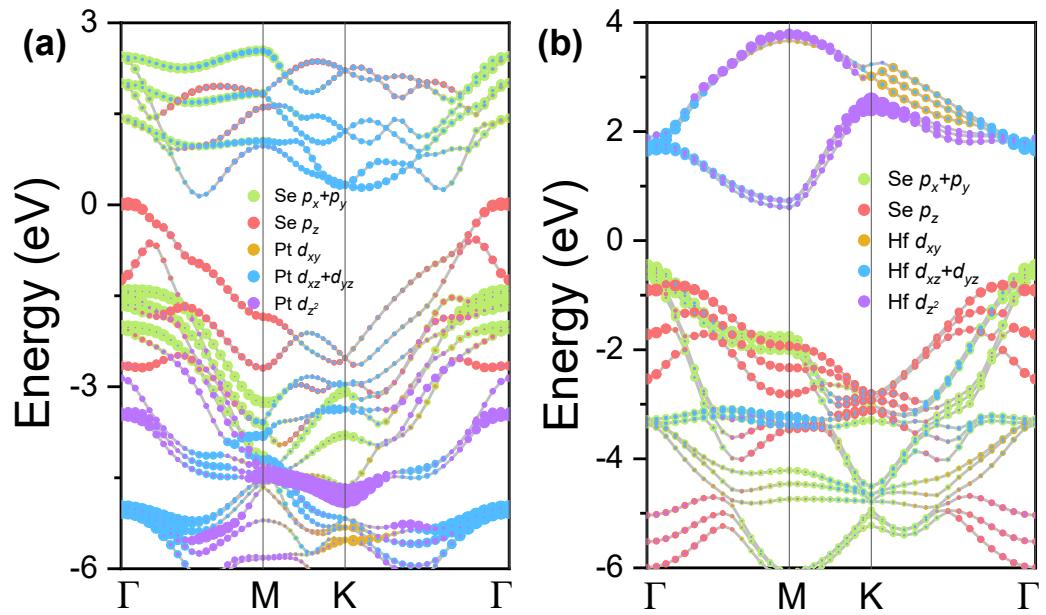


Fig. S2 Projected band structure of (a) 3L-PtSe₂ and (b) 3L-HfSe₂. The Fermi level position is set to energy zero point.

S6. Projected density of states of 2D PtSe₂ and HfSe₂

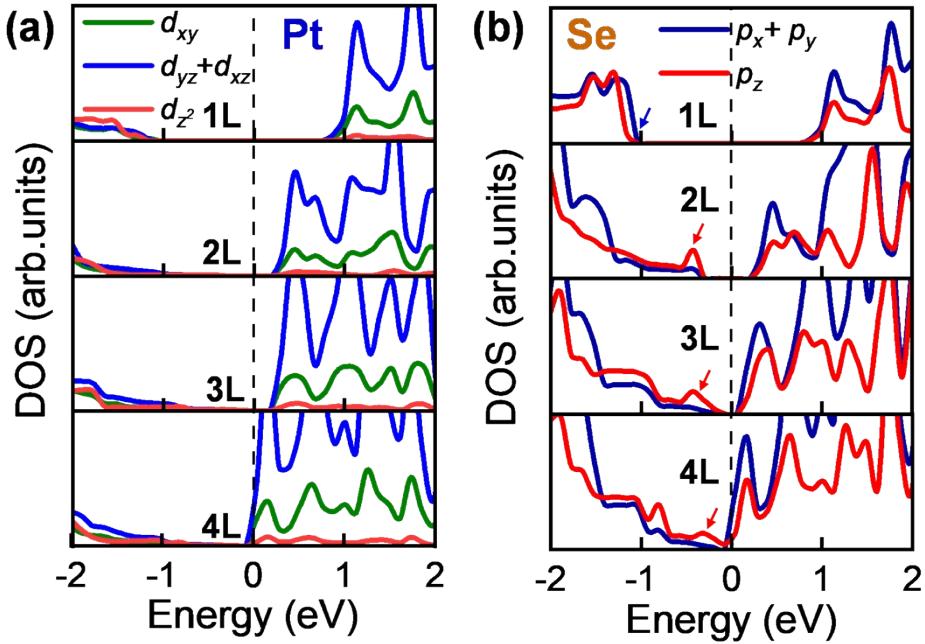


Fig. S3 Projected density of states of (a) Pt and (b) Se atoms in 2D PtSe₂ with the range of layer number from 1L to 4L. The dash lines denote the position of Fermi level.

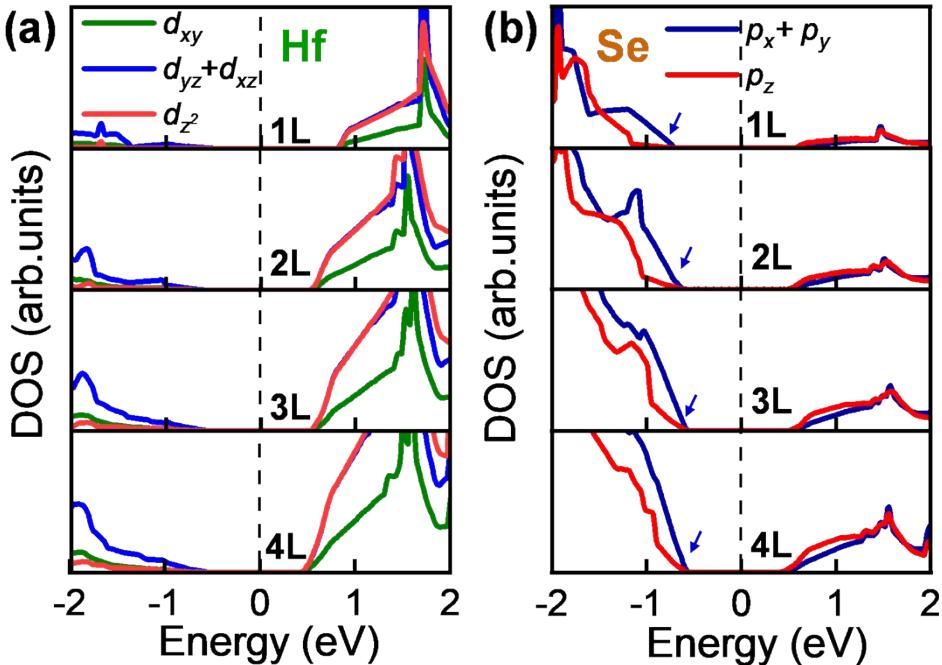


Fig. S4 Projected density of states of (a) Hf and (b) Se atoms in 2D HfSe₂ with the range of layer number from 1L to 4L. The dash lines denote the position of Fermi level.

S7. Transmission spectra of 2D PtSe₂ and HfSe₂ devices

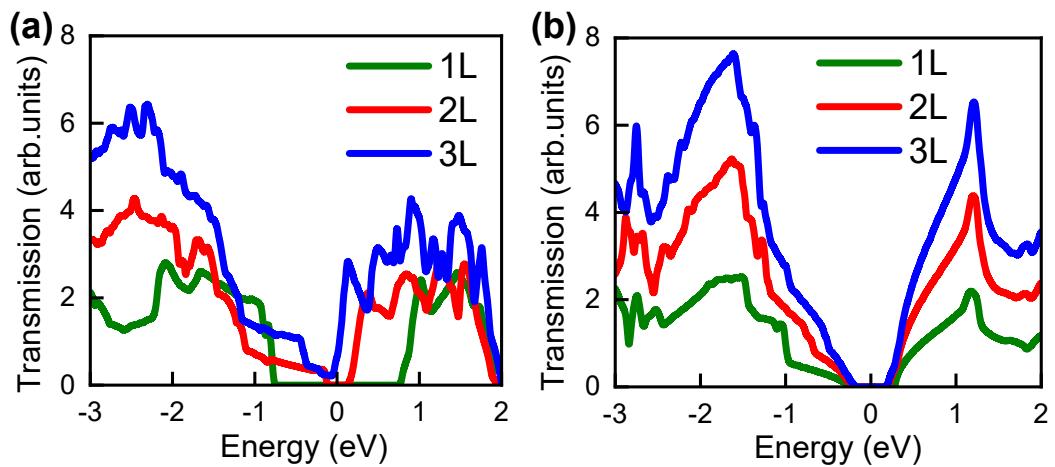


Fig. S5 Transmission spectra of 2D (a) PtSe₂ and (b) HfSe₂ devices with the range of layer number from 1L to 3L.

S8. Polarized photocurrent of 2D PtSe₂ and HfSe₂ under different photon energies

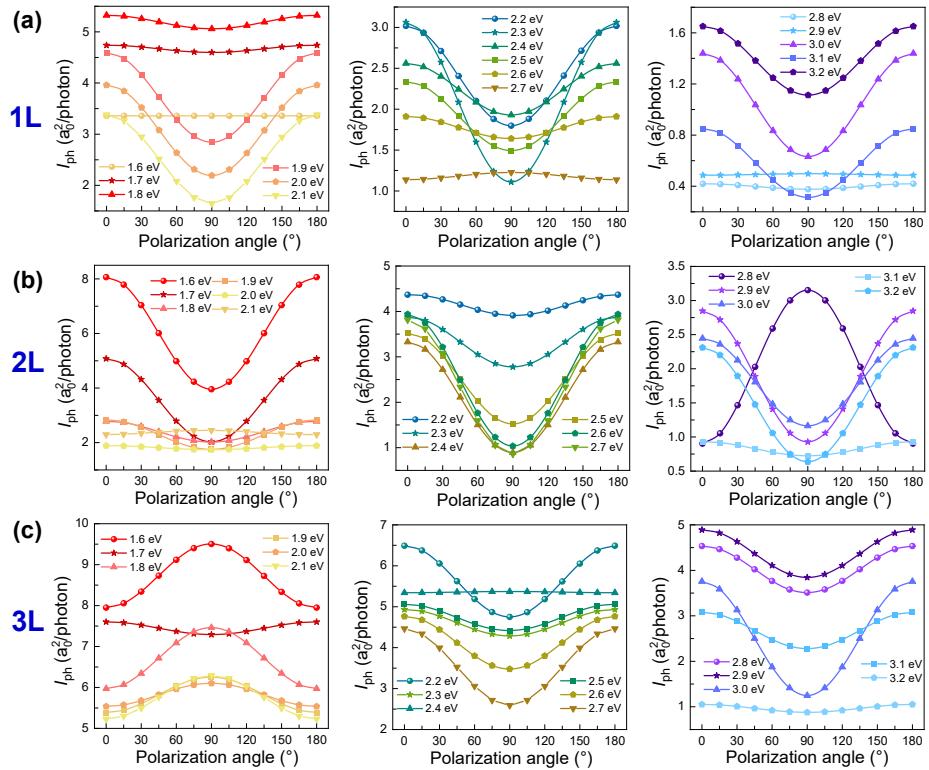


Fig. S6 The polarized I_{ph} of (a) 1L-PtSe₂, (b) 2L-PtSe₂, and (c) 3L-PtSe₂ devices as a function of polarization angle under different photon energies.

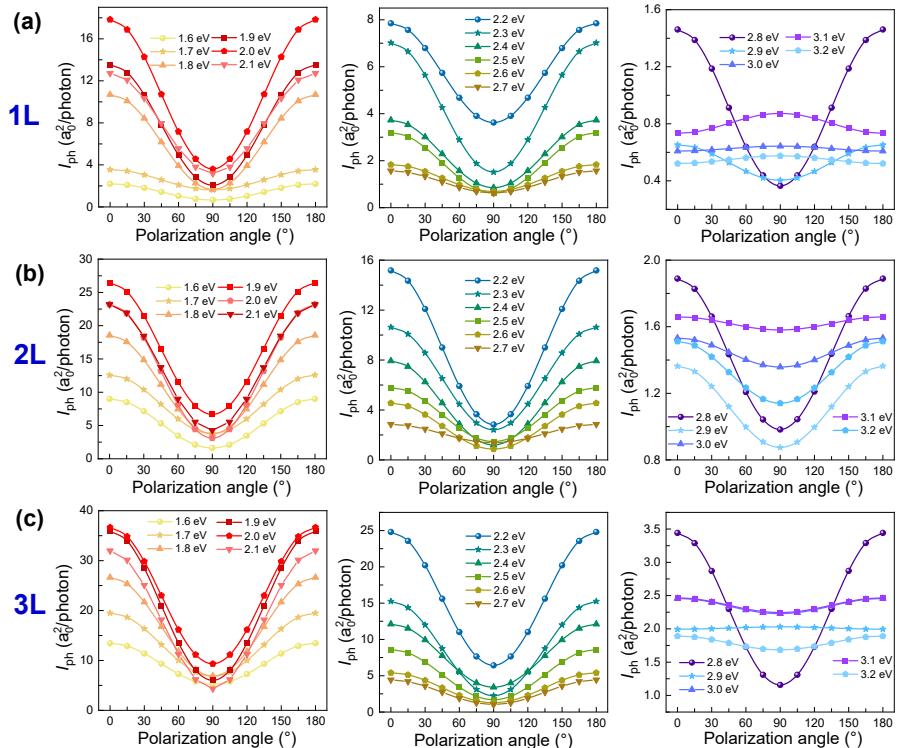


Fig. S7 The polarized I_{ph} of (a) 1L-HfSe₂, (b) 2LHfSe₂, and (c) 3L-HfSe₂ devices as a function of polarization angle under different photon energies.

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